Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO. 244945US2S		SERIAL NO. New Application	
(Modified)		PATENT AND TRAD	EMARK OFFICE				
			APPLICANT				
LIST OF REFERENCES CITED BY APPLICANT				Fumitaka ARAI, et al.			
				FILING DATE		GROUP	
				Herewith			
U.S. PATENT DOCUMENTS							
EXAMINER DOCUMENT DATE				NAME CLASS		SUB FILING DATE	
INITHAL		NUMBER	DATE	NAME	CLASS	CLASS	IF APPROPRIATE
(~	AA	<u>5,5</u> 55,204	09/10/96	Tetsuo ENDOH, et al.			
	AB	6,549,464	04/15/2003	Tomoharu TANAKA, et al.			>
	AC	6,434,055	08/13/2002	Tomoharu TANAKA, et al.	_		
	AD	6,208,560	03/27/2001	Tomoharu TANAKA, et al.		<u> </u>	
	AE	6,134,140	10/17/2000	Tomoharu TANAKA, et al.			
	AF	6,493,265	12/10/2002	Shinji SATOH, et al.			
1	AG	6,459,612	10/01/2002	Shinji SATOH, et al.			<u> </u>
	AH	6,314,026	11/06/2001	Shinji SATOH, et al.			
	Al						
	AJ						
	AK						
	AL						
	АМ						
	AN						•
FOREIGN PATENT DOCUMENTS							
	DOCUMENT					TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY		YES	
	AO	8-87895	04/02/96	JAPAN			_ X
(\mathcal{D})	AP	7-169284	07/04/95	JAPAN	<u> </u>		X
	AQ			•			· · · · · · · · · · · · · · · · · · ·
	AR						
	AS						
	AT				<u>:</u>		· · · · · · · · · · · · · · · · · · ·
	AU					ļ	
	AV			-		L	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	_AW						
	AX						
	AY	. \					
	ÀŻ	Additional References sheet(s) att					
Examiner Aubuors					Date Considered 7/07		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							